WHAT IS CLAIMED IS:

- 1. A lithographic projection apparatus, comprising:
 - a radiation system constructed to provide a beam of radiation;
- a support structure to support a patterning device, said patterning device serving to pattern said beam of radiation according to a desired pattern and form a patterned beam;
 - a substrate table for supporting a substrate;
- a projection system that projects said patterned beam onto a target portion of said substrate; and

at least one holding structure having at least one compliant member constructed to hold a pimple plate, said pimple plate constructed to hold one of said patterning device and said substrate.

- 2. A lithographic projection apparatus according to claim 1, wherein said at least one compliant member includes a membrane.
- 3. A lithographic projection apparatus according to claim 1, wherein said at least one compliant member includes a pair of parallel flaps.
- 4. A lithographic projection apparatus according to claim 3, wherein each of said pair of parallel flaps is supported along the respective length of each of said pair of parallel flaps.
- 5. A lithographic projection apparatus according to claim 1, wherein said pimple plate is substantially rigid in comparison with said at least one compliant member.
- 6. A lithographic projection apparatus according to claim 1, further comprising:
- a plurality of supports for supporting said at least one of said patterning device and said substrate and each of said plurality of supports extending substantially perpendicular to a plane of said at least one of said patterning device and said substrate.

- 7. A lithographic projection apparatus according to claim 6, wherein said plurality of supports are arranged to support said pimple plate at Bessel points.
- 8. A lithographic projection apparatus according to claim 7, wherein said plurality of supports is three fixed supports.
- 9. A lithographic projection apparatus according to claim 6, wherein at least one of said plurality of supports provides electrical contact with said pimple plate.
- 10. A lithographic projection apparatus according to claim 1, further comprising:

an electrostatic clamp constructed to clamp said pimple plate to at least one of said one of said patterning device and said substrate and said at least one compliant member.

- 11. A lithographic projection apparatus according to claim 1, wherein said beam of radiation comprises EUV radiation.
- 12. A lithographic projection apparatus according to claim 1, wherein said at least one of said support structure and said substrate table includes said at least one holding structure.
- 13. A method of manufacturing a device using a lithographic projection apparatus comprising:

providing a beam of radiation;

providing a support structure for supporting a patterning device;

using the patterning device to pattern the beam of radiation according to a desired pattern forming a patterned beam;

providing a substrate table for supporting a substrate;

holding one of the patterned beam and the substrate on a pimple plate during operation of the apparatus;

holding the pimple plate on at least one compliant member; and projecting the patterned beam onto a target portion of the substrate.

14. A lithographic projection apparatus, comprising:

means for projecting said patterned beam of radiation onto a target portion of a substrate;

holding means for holding at least one of a patterning device and said substrate; and means for resiliently supporting said holding means.

15. A lithographic projection apparatus, comprising:

a radiation system constructed to provide a beam of radiation;

a pimple plate having protrusions extending from a surface, said pimple plate constructed to hold a removable item on said protrusions;

a holding structure having at least one compliant member constructed to resiliently hold said pimple plate.

16. A lithographic projection apparatus according to claim 15, wherein:

said removable item is one of a patterning device serving to pattern said beam of radiation according to a desired pattern and form a patterned beam and a substrate.